

**Search Notes**

Application/Control No.

10/676,659

Examiner

Hanh Nguyen

Applicant(s)/Patent under  
Reexamination

CHAVEZ ET AL.

Art Unit

2616

**SEARCHED**

Class	Subclass	Date	Examiner
370	352	8/20/2007	HN
	401		
	389		
	225		
	216		
	218		
	219		
	242		
370	356	8/20/07	

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east	8/20/2007	HN